

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination BUECHLER ET AL.	
		09/776,599	Examiner	Art Unit Jon D Epperson

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*	C	US-5,254,887	10-1993	Oguri, Takashi	326/66
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**NON-PATENT DOCUMENTS**

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